# MOSFET – Power, Dual N-Channel, Logic Level, Dual SO8FL 60 V, 39 mΩ, 17 A

## Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVMFD5877NLWF Wettable Flanks Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

| Parameter  |  |                         | Symbol                            | Value          | Unit |
|--|--|-------------------------|-----------------------------------|----------------|------|
| Drain-to-Source Voltage  |  |                         | V <sub>DSS</sub>                  | 60             | V    |
| Gate-to-Source Voltage   |  |                         | V <sub>GS</sub>                   | ±20            | V    |
| Continuous Drain Current $R_{\Psi J-mb}$ (Notes 1, 2, 3, 4)  | Steady<br>State                              | T <sub>mb</sub> = 25°C  | Ι <sub>D</sub>                    | 17             | А    |
|  |  | $T_{mb} = 100^{\circ}C$ |                                   | 12             |      |
| Power Dissipation $R_{\Psi J-mb}$ (Notes 1, 2, 3)  |  | T <sub>mb</sub> = 25°C  | PD                                | 23             | W    |
|  |  | $T_{mb} = 100^{\circ}C$ |                                   | 12             |      |
| $\begin{array}{l} \mbox{Continuous Drain Current $R_{\theta JA}$ (Notes 1 \& 3, 4) \\ \hline \mbox{Power Dissipation} $R_{\theta JA}$ (Notes 1, 3) \\ \end{array}$ |  | $T_A = 25^{\circ}C$     | Ι <sub>D</sub>                    | 6              | А    |
|  | Steady<br>State                              | T <sub>A</sub> = 100°C  |                                   | 5              |      |
|  |  | T <sub>A</sub> = 25°C   | PD                                | 3.2            | W    |
|  |  | T <sub>A</sub> = 100°C  |                                   | 1.6            |      |
| Pulsed Drain Current   | $T_A = 25^{\circ}C$ , $t_p = 10 \ \mu s$     |                         | I <sub>DM</sub>                   | 74             | А    |
| Operating Junction and Storage Temperature   |  |                         | T <sub>J</sub> , T <sub>stg</sub> | –55 to<br>+175 | °C   |
| Source Current (Body Diode)  |  |                         | IS                                | 19             | А    |
| Single Pulse Drain–<br>to–Source Avalanche<br>Energy ( $T_J = 25^{\circ}C$ ,   | (I <sub>L(pk)</sub> = 14.5 A, L =<br>0.1 mH) |                         | E <sub>AS</sub>                   | 10.5           | mJ   |
| $V_{DD} = 24 \text{ V}, V_{GS} = 10 \text{ V}, R_G = 25 \Omega$  | (I <sub>L(pk)</sub> = 6.3 A, L = 2 mH)       |                         |                                   | 40             |      |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s)  |  | ΤL                      | 260                               | °C             |      |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

| Parameter  | Symbol          | Value | Unit |
|--|-----------------|-------|------|
| Junction-to-Mounting Board (top) - Steady<br>State (Note 2, 3) | $R_{\Psi J-mb}$ | 6.5   | °C/W |
| Junction-to-Ambient - Steady State (Note 3)                    | $R_{\theta JA}$ | 47    |      |

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

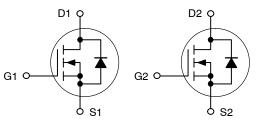


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| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| 60 V                 | 39 mΩ @ 10 V            | 17 A               |
|                      | 60 mΩ @ 4.5 V           |                    |







W = Work Week

ZZ = Lot Traceability

#### **ORDERING INFORMATION**

| Device           | Package           | Shipping <sup>†</sup> |  |  |
|------------------|-------------------|-----------------------|--|--|
| NVMFD5877NLT1G   | DFN8<br>(Pb-Free) | 1500 / Tape &<br>Reel |  |  |
| NVMFD5877NLWFT1G | DFN8<br>(Pb-Free) | 1500 / Tape &<br>Reel |  |  |
| NVMFD5877NLT3G   | DFN8<br>(Pb-Free) | 5000 / Tape &<br>Reel |  |  |
| NVMFD5877NLWFT3G | DFN8<br>(Pb-Free) | 5000 / Tape &<br>Reel |  |  |

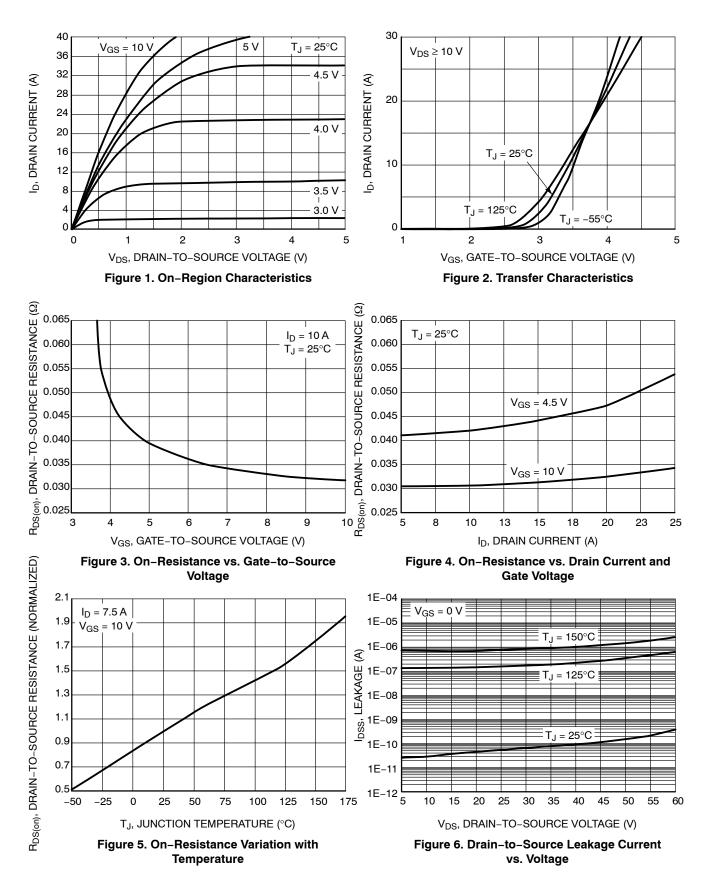
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

- Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
  Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
  Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

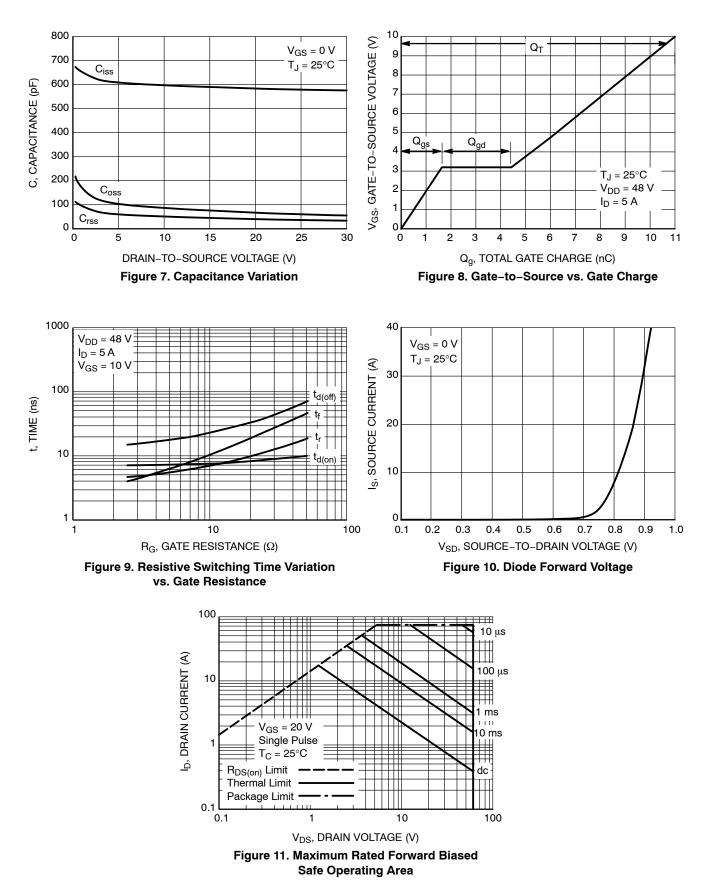
| Parameter  | Symbol                               | Test Cond   | ition  | Min | Тур   | Max  | Unit  |
|--|--------------------------------------|---|--|-----|-------|------|-------|
| OFF CHARACTERISTICS  |                                      |   |  |     | -     | -    | •     |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                 | $V_{GS}$ = 0 V, I <sub>D</sub> = 250 µA   |  | 60  |       |      | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /T <sub>J</sub> |   |  |     | 53    |      | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                     | V <sub>GS</sub> = 0 V,  | $T_J = 25^{\circ}C$                          |     |       | 1.0  | μΑ    |
|  |                                      | V <sub>DS</sub> = 60 V  | $T_J = 125^{\circ}C$                         |     |       | 10   |       |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                     | $V_{DS} = 0 V, V_{GS}$  | = ±20 V                                      |     |       | ±100 | nA    |
| ON CHARACTERISTICS (Note 5)                                  |                                      |   |  |     |       |      |       |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                  | $V_{GS} = V_{DS}, I_D$  | = 250 μA                                     | 1.0 |       | 3.0  | V     |
| Negative Threshold Temperature<br>Coefficient                | V <sub>GS(TH)</sub> /T <sub>J</sub>  |   |  |     | 3.5   |      | mV/°C |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                  | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 7.5 A                       |     | 31    | 39   | mΩ    |
|  |                                      | V <sub>GS</sub> = 4.5 V   | I <sub>D</sub> = 7.5 A                       |     | 42    | 60   |       |
| Forward Transconductance                                     | 9 <sub>FS</sub>                      | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 5.0 A  |  |     | 7.0   |      | S     |
| CHARGES AND CAPACITANCES                                     |                                      |   |  |     |       |      |       |
| Input Capacitance  | C <sub>iss</sub>                     |   |  |     | 540   |      | pF    |
| Output Capacitance   | C <sub>oss</sub>                     | V <sub>GS</sub> = 0 V, f = 1.0 Mł   | $V_{GS}$ = 0 V, f = 1.0 MHz, $V_{DS}$ = 25 V |     | 55    |      | 1     |
| Reverse Transfer Capacitance                                 | C <sub>rss</sub>                     |   |  |     | 36    |      |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                  |   |  |     | 5.9   |      | nC    |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                   | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 48 V,  |  |     | 0.62  |      | ]     |
| Gate-to-Source Charge  | Q <sub>GS</sub>                      | l <sub>D</sub> = 5.0  | A  |     | 1.64  |      | -     |
| Gate-to-Drain Charge   | Q <sub>GD</sub>                      |   |  |     | 2.80  |      |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                  | V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 4   | 18V, I <sub>D</sub> = 5.0A                   |     | 11    | 20   | nC    |
| SWITCHING CHARACTERISTICS (No                                | ote 6)                               |   |  |     |       |      |       |
| Turn-On Delay Time   | t <sub>d(on)</sub>                   |   |  |     | 8.1   |      | ns    |
| Rise Time  | t <sub>r</sub>                       | V <sub>GS</sub> = 4.5 V, V <sub>D</sub>   | <sub>S</sub> = 48 V,                         |     | 15.8  |      |       |
| Turn-Off Delay Time  | t <sub>d(off)</sub>                  | I <sub>D</sub> = 5.0 A, R <sub>G</sub>  | = 2.5 Ω                                      |     | 11.8  |      |       |
| Fall Time  | t <sub>f</sub>                       |   |  |     | 3.9   |      |       |
| Turn-On Delay Time   | t <sub>d(on)</sub>                   |   |  |     | 4.9   |      | ns    |
| Rise Time  | t <sub>r</sub>                       | V <sub>GS</sub> = 10 V, V <sub>D</sub>  |  |     | 6.4   |      |       |
| Turn–Off Delay Time  | t <sub>d(off)</sub>                  | $I_D$ = 5.0 A, $R_G$ = 2.5 $\Omega$   |  |     | 14.5  |      |       |
| Fall Time  | t <sub>f</sub>                       |   |  |     | 2.4   |      |       |
| DRAIN-SOURCE DIODE CHARACTE                                  | RISTICS                              |   |  |     |       |      |       |
| Forward Diode Voltage  | V <sub>SD</sub>                      | V <sub>GS</sub> = 0 V,  | $T_J = 25^{\circ}C$                          |     | 0.8   | 1.2  | V     |
|  |                                      | $I_{\rm S} = 5.0 \rm A$   | $T_J = 125^{\circ}C$                         |     | 0.7   |      |       |
| Reverse Recovery Time  | t <sub>RR</sub>                      | $V_{GS} = 0 \text{ V}, \text{ d}_{IS}/\text{d}_{t} = 100 \text{ A}/\mu\text{s},$<br>$I_{S} = 5.0 \text{ A}$ |  |     | 14.5  |      | ns    |
| Charge Time  | t <sub>a</sub>                       |   |  |     | 11.5  |      |       |
| Discharge Time   | t <sub>b</sub>                       |   |  |     | 3.1   |      |       |
| Reverse Recovery Charge                                      | Q <sub>RR</sub>                      |   |  |     | 11    |      | nC    |
| PACKAGE PARASITIC VALUES                                     |                                      |   |  |     |       |      |       |
| Source Inductance  | L <sub>S</sub>                       | T <sub>A</sub> = 25°C   |  |     | 0.93  |      | nH    |
| Drain Inductance   | L <sub>D</sub>                       |   |  |     | 0.005 |      |       |
| Gate Inductance  | L <sub>G</sub>                       |   |  |     | 1.84  |      |       |
| Gate Resistance  | R <sub>G</sub>                       |   |  |     | 1.5   |      | Ω     |

5. Pulse Test: pulse width = 300  $\mu$ s, duty cycle  $\leq 2\%$ . 6. Switching characteristics are independent of operating junction temperatures.

# **TYPICAL CHARACTERISTICS**



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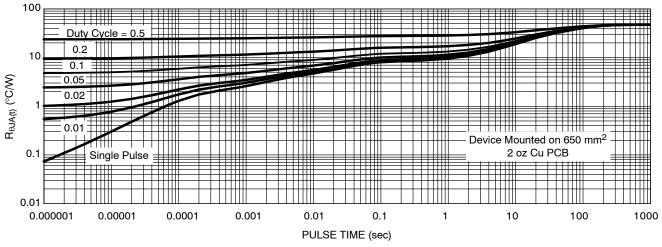
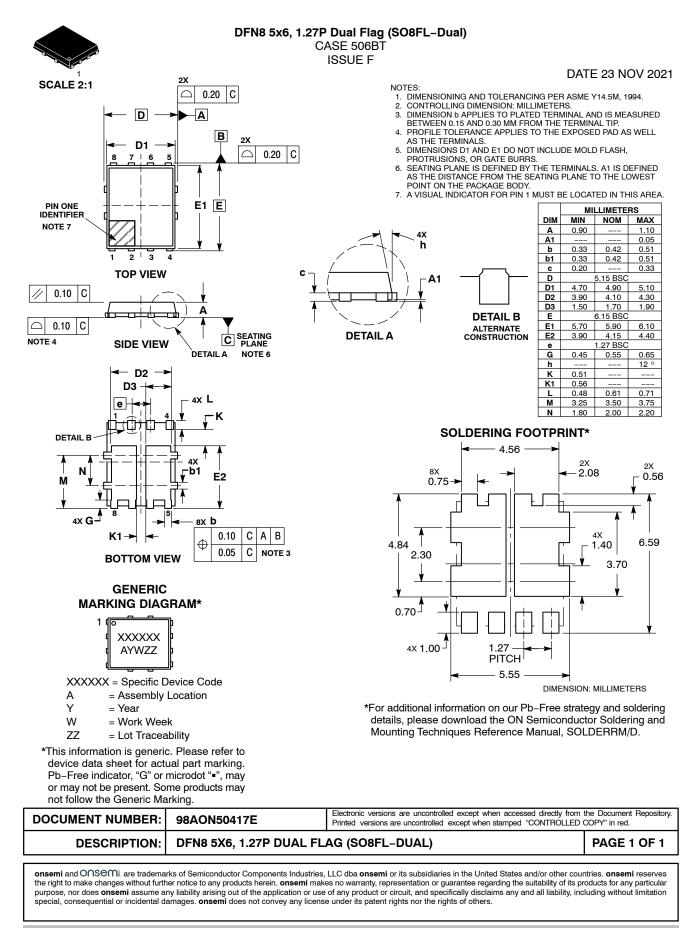


Figure 12. Thermal Response

#### MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

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